

February 2004

FDS7064N7

30V N-Channel PowerTrench® MOSFET

General Description

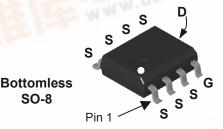
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low $R_{\text{DS(ON)}}$ in a small package.

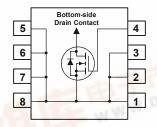
Applications

- · Synchronous rectifier
- DC/DC converter

Features

- 16.5 A, 30 V $R_{DS(ON)} = 7.0 \text{ m}\Omega \text{ @ }V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low R_{DS(ON)}
- · High power and current handling capability
- · Fast switching
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V_{DSS}	Drain-Source Voltage		30	V	
V _{GSS}	Gate-Source Voltage		± 12	V	
I _D	Drain Current - Continuous	(Note 1a)	16.5	Α	
	- Pulsed		60	A TOY	
P _D	Power Dissipation for Single Operation	(Note 1a)	3.0	W	
T _J , T _{STG}	Operating and Storage Junction Temperat	ture Range	-55 to +150	°C	

Thermal Characteristics

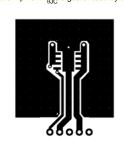
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	40	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.5	°C/W

Package Marking and Ordering Information

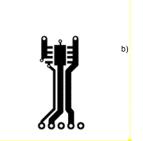
Device Marking	Device	Reel Size	Tape width	Quantity
FDS7064N7	FDS7064N7	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 12 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate–Body Leakage, Reverse	$V_{GS} = -12 \text{ V}$, $V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.8	1.2	2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-4.3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	V_{GS} = 4.5 V, I_D = 16.5 A V_{GS} = 4.5 V, I_D = 16.5 A, T_J = 125°C		5.7 8.4	7.0 10.5	mΩ
g _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 16.5 A		112		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V,		3355		pF
Coss	Output Capacitance	f = 1.0 MHz		522		pF
C _{rss}	D + (0 :					
Orss	Reverse Transfer Capacitance			209		pF
	•			209		pF
Switchir	ng Characteristics (Note 2) Turn-On Delay Time	V _{DD} = 15 V, I _D = 1 A,		17	30	pF ns
Switchir t _{d(on)}	ng Characteristics (Note 2)	V_{DD} = 15 V, I_{D} = 1 A, V_{GS} = 4.5 V, R_{GEN} = 6 Ω			30 23	•
Switchir t _{d(on)} t _r	Turn-On Delay Time	_ == : = :		17		ns
Switchir t _{d(on)}	Turn-On Rise Time	_ == : = :		17 13	23	ns ns
Switchir t _{d(on)} t _r t _{d(off)}	Turn-On Rise Time Turn-Off Delay Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$ $V_{DS} = 15 \text{ V}, I_{D} = 16.5 \text{ A},$		17 13 54	23 86	ns ns ns
Switchir t _{d(on)} t _r	Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$		17 13 54 26	23 86 42	ns ns ns
Switchir td(on) tr td(off) tf Qg Qgs	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$ $V_{DS} = 15 \text{ V}, I_{D} = 16.5 \text{ A},$		17 13 54 26 30	23 86 42	ns ns ns ns
Switchin td(on) tr td(off) tf Qg Qgs Qgd	Turn-On Delay Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$ $V_{DS} = 15 \text{ V}, I_{D} = 16.5 \text{ A},$ $V_{GS} = 4.5 \text{ V}$		17 13 54 26 30 6.3	23 86 42	ns ns ns ns nc
Switchin td(on) tr t td(off) tf Qg Qgs Qgd	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	V_{GS} = 4.5 V, R_{GEN} = 6 Ω V_{DS} = 15 V, I_{D} = 16.5 A, V_{GS} = 4.5 V		17 13 54 26 30 6.3	23 86 42	ns ns ns ns nc

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



40°C/W when mounted on a 1in² pad of 2 oz copper



85°C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

Typical Characteristics

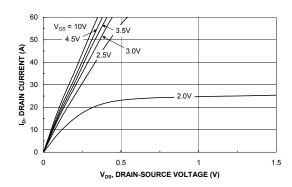


Figure 1. On-Region Characteristics.

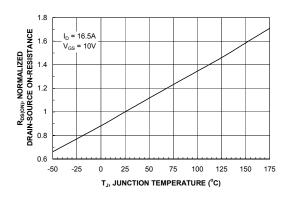


Figure 3. On-Resistance Variation withTemperature.

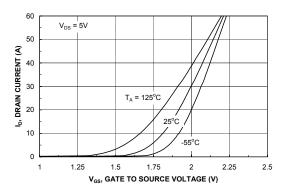


Figure 5. Transfer Characteristics.

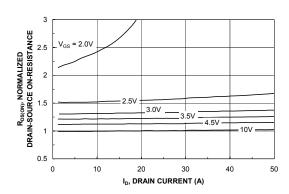


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

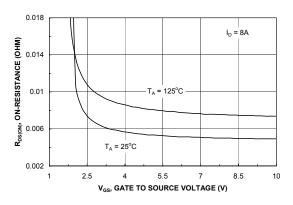


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

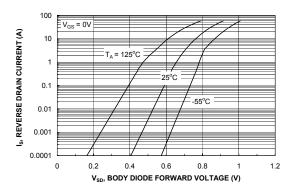
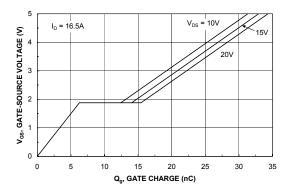


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



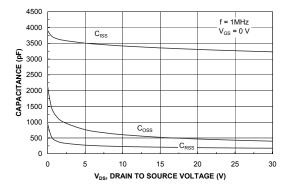


Figure 7. Gate Charge Characteristics.

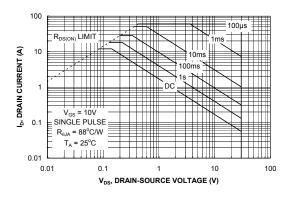


Figure 8. Capacitance Characteristics.

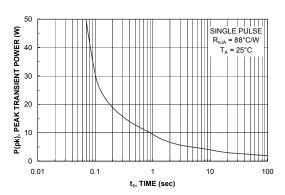


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

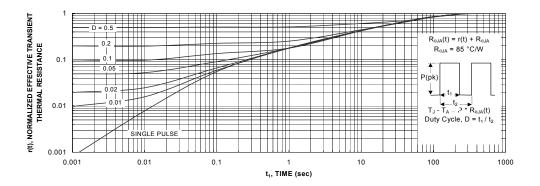
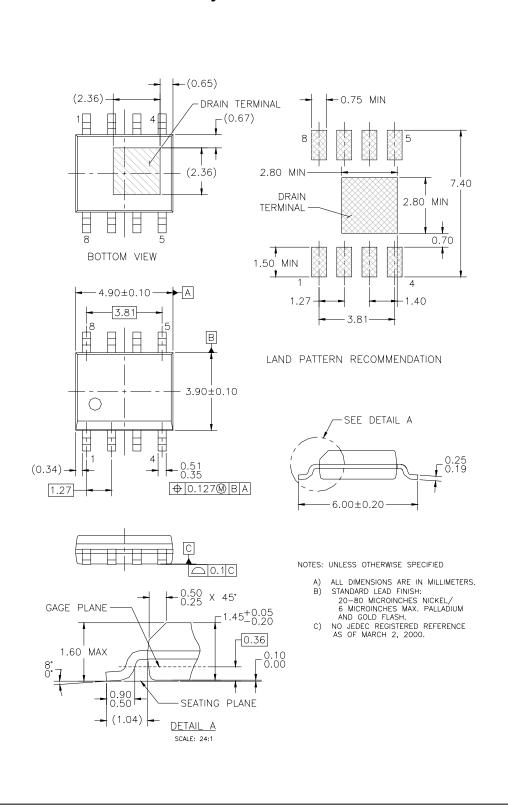


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

Dimensional Outline and Pad Layout



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